

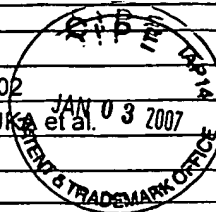
SECOND INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet 1 of 1

Complete if Known

Application Number	10/081,234
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First Named Inventor	Hirofumi TOTSUKA et al.
Examiner Name	Unassigned
Attorney Docket Number	027260-515



U.S. PATENT DOCUMENTS

Examiner Initials	Document Number	Kind Code (if known)	Name of Patentee or Applicant of Cited Document	Issue/Publication Date (MM-DD-YYYY)
QZW	4,926,425		Hedtke et al.	05-15-1990
	5,802,073		Platt	09-01-1998
V	5,787,114		Ramamurthy et al.	07-28-1998

FOREIGN PATENT DOCUMENTS

Examiner Initials	Document Number	Kind Code (if known)	Country	Date of Publication (MM-DD-YYYY)	Translation	
					Yes	No

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
QZW	N. Mukherjee, et al., "Built-In Self-Test: A Complete Test Solution for Telecommunication Systems", IEEE Communications Magazine, Vol. 37, No. 6, June 1999, pages 72-78
QZW	M. Gagnon, et al., "Optical Communication Channel Test Using Bist Approaches", Proceedings of the International Test Conference, ITC 1997, IEEE, Vol. Conf. 28, November 1, 1997, pages 626-635

VA 49529.1

Examiner Signature	<i>Stephen W. [Signature]</i>	Date Considered	1/23/2007
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 608. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.